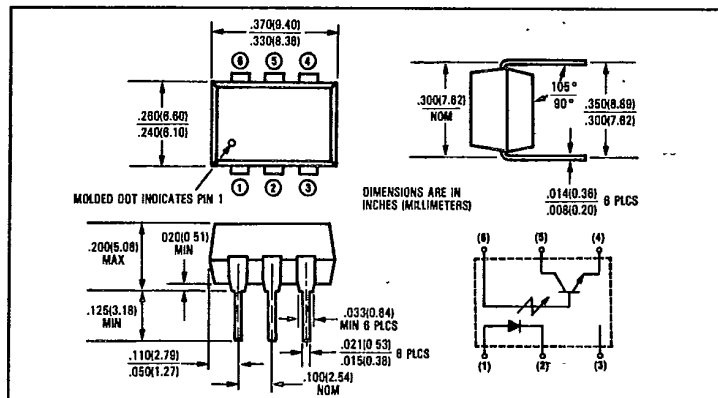
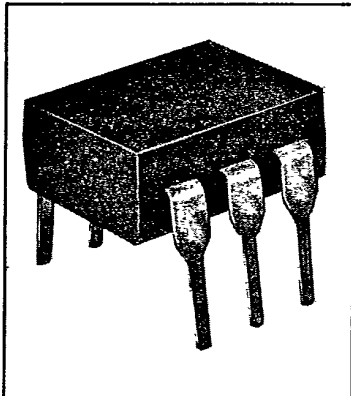


Optically Coupled Isolators Types OPI2152, OPI2252



Features

- 1500 or 2500 volt isolation
- High current transfer ratio
- Low cost 6 pin dual-in-line package
- UL recognized File No. E58730

Description

The OPI2152 and OPI2252 each consist of a gallium arsenide infrared light emitting diode coupled to an NPN silicon phototransistor mounted in a six pin dual-in-line package. The OPI2152 and OPI2252 are identical except for input-to-output isolation voltage.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Input-to-Output Isolation Voltage OPI2152 $\pm 1500\text{ VDC}^{(1)}$
OPI2252 $\pm 2500\text{ VDC}^{(1)}$

Storage Temperature Range -55°C to $+150^\circ\text{C}$

Operating Temperature Range -55°C to $+100^\circ\text{C}$

Lead Soldering Temperature (1/16 inch (1.6 mm) from case for 5 sec. with soldering iron)⁽²⁾ 260°C

Input Diode

Forward DC Current 60 mA

Peak Forward Current (1 μs pulse, 300 pps) 3.0 A

Reverse Voltage 3.0 V

Power Dissipation (25°C) 100 mW⁽³⁾

Output Transistor

Power Dissipation 150 mW⁽⁴⁾

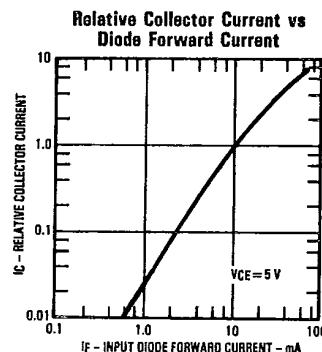
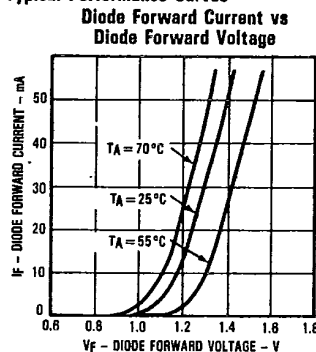
BIBRICEO 30 V

VIBRICEO 50 V

VIBRICEO 5.0 V

Notes: (1) Measured with input diode leads shorted together and output leads shorted together. (2) RMA flux is recommended. Duration can be extended to 10 sec. max. when flow soldering. (3) Derate linearly 1.33 mW/ $^\circ\text{C}$ above 25°C . (4) Derate linearly 2.0 mW/ $^\circ\text{C}$ above 25°C .

Typical Performance Curves



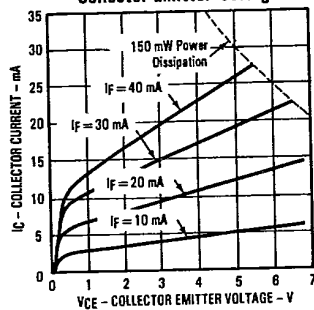
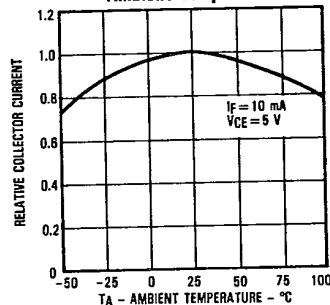
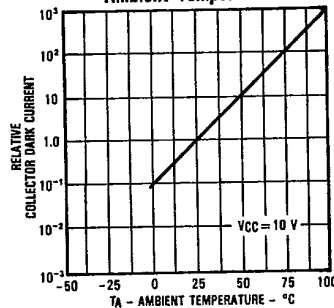
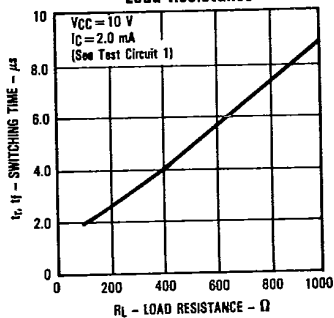
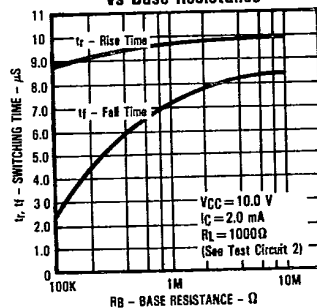
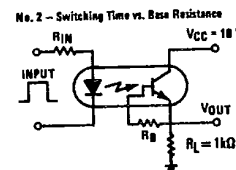
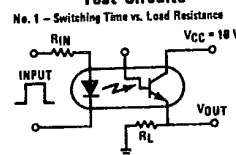
Types OPI2152, OPI2252

T-41-83

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Input Diode						
V_F	Forward Voltage			1.50	V	$I_F = 10.0\text{ mA}$
V_{BR}/I_R	Reverse Breakdown Voltage	3.0			V	$I_R = 10.0\text{ }\mu\text{A}$
I_R	Reverse Leakage Current			10.0	μA	$V_R = 3.0\text{ V}$
Output Phototransistor						
$V_{(BR)CEO}$	Collector-to-Emitter Breakdown Voltage	30			V	$I_C = 1.00\text{ mA}$
$V_{(BR)ECO}$	Emitter-to-Collector Breakdown Voltage	5.0			V	$I_E = 10.0\text{ }\mu\text{A}$
$V_{(BR)CBO}$	Collector-to-Base Breakdown Voltage	50			V	$I_C = 10.0\text{ }\mu\text{A}$
I_{CEO}	Collector-Emitter Dark Current		5.0	50	nA	$V_{CE} = 10.0\text{ V}$
I_{CBO}	Collector-Base Dark Current			20	nA	$V_{CB} = 10.0\text{ V}$
C_{CE}	Capacitance Collector-to-Emitter		8.0		pF	$V_{CE} = 0$
h_{FE}	DC Current Gain		250			$V_{CE} = 5.0\text{ V}, I_C = 100\text{ }\mu\text{A}$
Coupled						
I_C/I_F	DC Current Transfer Ratio	20	40		%	$I_F = 10.0\text{ mA}, V_{CE} = 5.0\text{ V}$
$V_{CE(SAT)}$	Collector-to-Emitter Saturation Voltage			0.40	V	$I_F = 10.0\text{ mA}, I_C = 500\text{ }\mu\text{A}$
V_{ISO}	Isolation Voltage OPI2152 OPI2252	1500 2500			VDC	See Note 1
R_{IO}	Input-to-Output Resistance	10^{11}			Ω	$V_{IO} = 500\text{ V}$, See Note 1
C_{IO}	Input-to-Output Capacitance		2.0		pF	$f = 1.00\text{ MHz}$, See Note 1
t_r	Output Rise Time		2.0		μs	$V_{CC} = 10.0\text{ V}, I_C = 2.0\text{ mA}$
t_f	Output Fall Time		2.0		μs	$R_L = 100\Omega$, See Test Circuit

Typical Performance Curves

Collector Current vs
Collector-Emitter VoltageRelative Collector Current vs
Ambient TemperatureRelative Collector Dark Current vs
Ambient TemperatureRise and Fall Time vs
Load ResistanceDelay, Rise, and Fall Time
vs Base ResistanceSwitching Time
Test Circuits

TRW reserves the right to make changes at any time in order to improve design and to supply the best product possible. Plastic color may vary.

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